The photocathode aging in MCP PMT

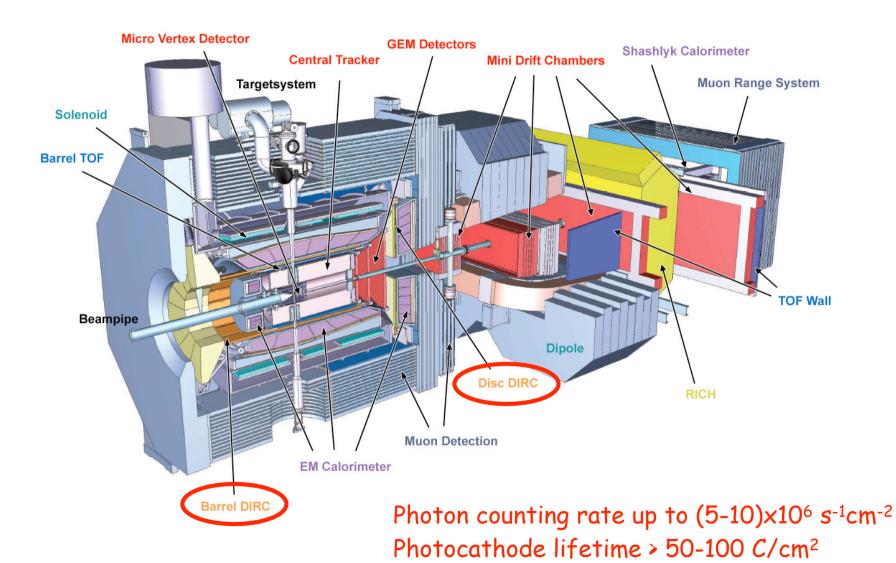
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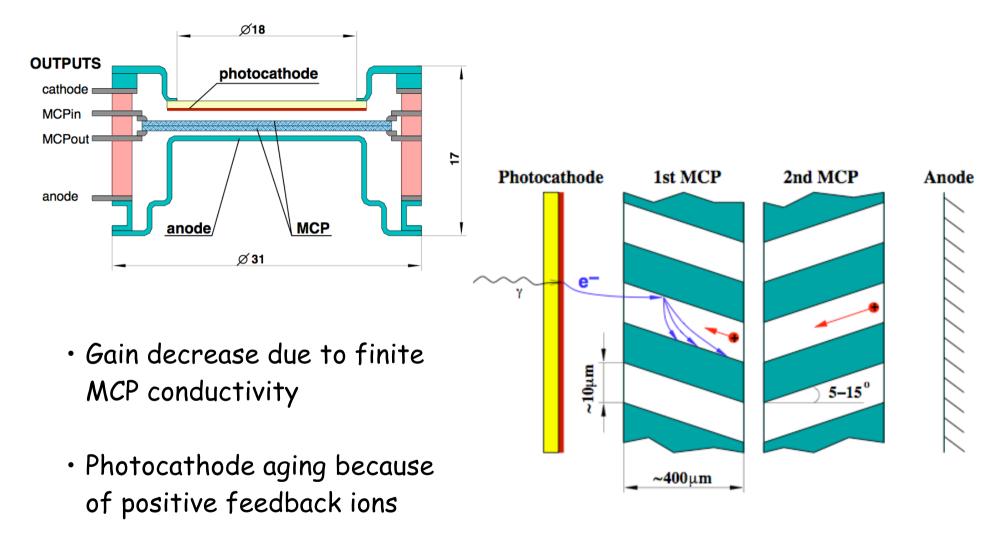
Outline:

- MCP PMT in PANDA
- Photocathode aging
- Lifetime estimation
- Conclusion

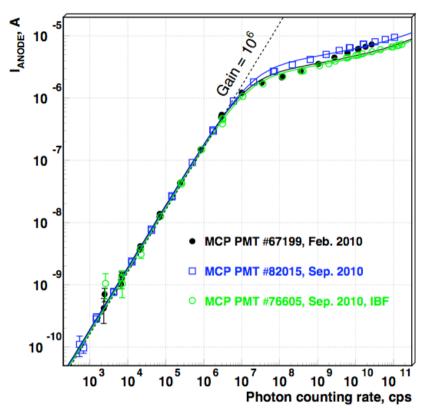
MCP PMT in PANDA

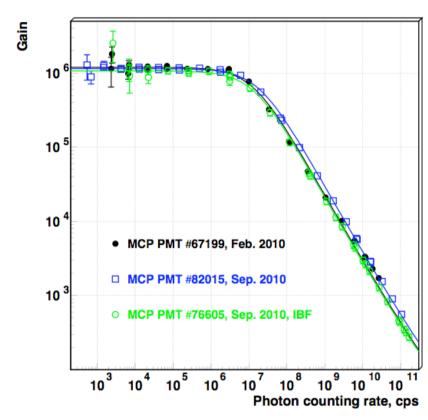


Scheme of MCP PMT



Gain decrease at high counting rate





$$I(z) = I_{in}e^{\alpha z} \ln(M_0) / F / (1+I_{in}/I_s \cdot e^{\alpha z})$$
where

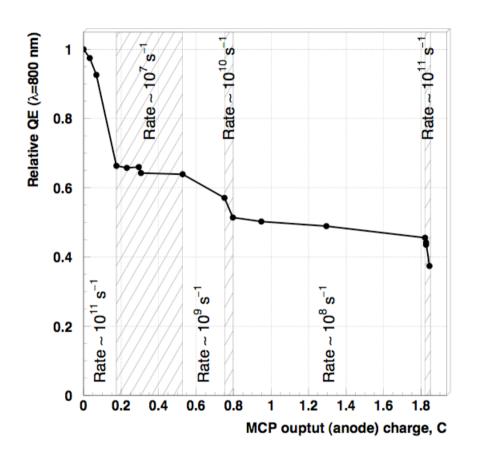
$$I(z) = I_{in}e^{\alpha z} \ln(M_0) / F / (1+I_{in}/I_s \cdot e^{\alpha z}) \quad \rightarrow \quad M = M_0 \cdot \ln(M_0) / F / (1+I_{in}/I_s \cdot e^{\alpha z})$$

$$F = \ln(M_0) + \ln(1 + I_{in}/I_s) - \ln(1 + I_{in}/I_s \cdot M_0)$$

$$\alpha = \ln(M_0)/L$$

A.B.Berkin and V.V.Vasilyev, Proc. of SPIE 5834(2005)218

QE degradation vs. anode charge

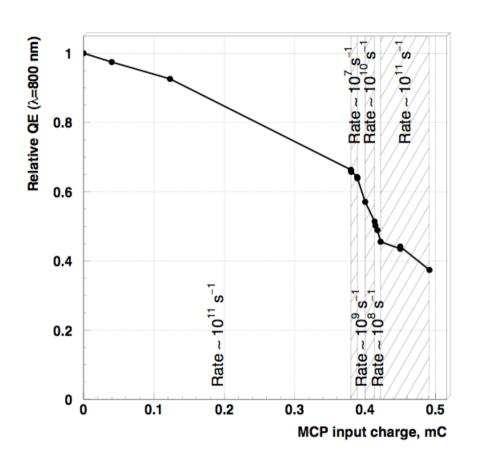


(AQE / QE,) / AQANODE, 1/C 10 H 10 $\lambda = 800 \text{ nm}$ 10 10 10 10 11 10 9 10 10⁸ Photon counting rate, cps

QE (λ=800nm) versus anode charge collected at different photon counting rates

Specific QE degradation versus photon counting rate

QE degradation vs. MCP input charge

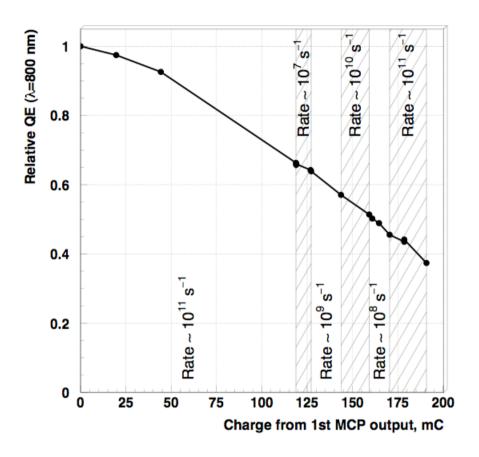


(AQE / QE₀) / AQ_{INPUT}, 1/mC 10 $\lambda = 800 \text{ nm}$ 10 10 10 11 10 9 10 10⁸ Photon counting rate, cps

QE (λ =800nm) versus MCP input charge collected at different photon counting rates

Specific QE degradation versus photon counting rate

QE degradation vs. charge from 1st MCP output

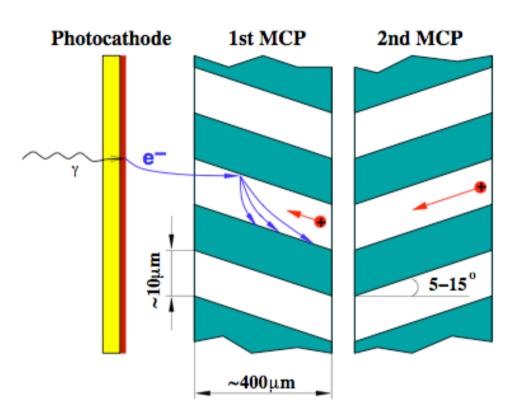


(AQE / QE₀) / AQ_{1st MCP}, 1/C 14 12 10 6 4 $\lambda = 800 \text{ nm}$ 2 0 10 10 10 11 10 9 10 10⁸ Photon counting rate, cps

QE (λ =800nm) versus charge from 1st MCP output collected at different photon counting rates

Specific QE degradation versus photon counting rate

Interpretation of results



Hypothesis: only ions produced in the 1st MCP can reach the photocathode.

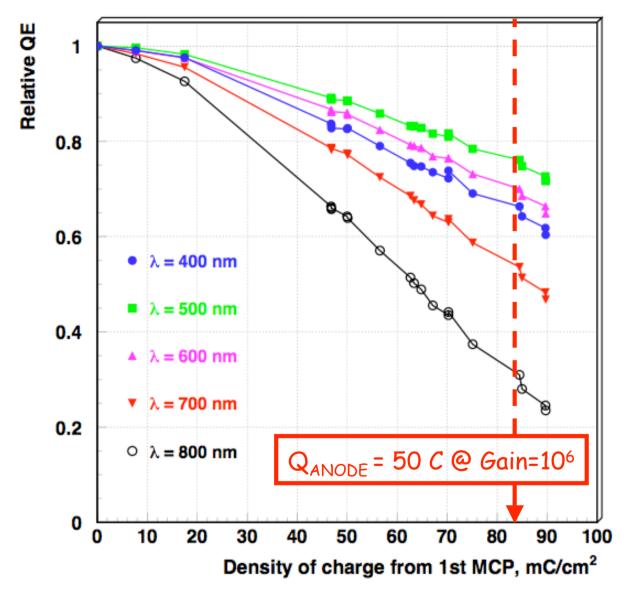
Then at low counting rate (in linear region) the QE degradation should be:

- proportional to collected output (and input) charge;
- 2. proportional to square (for 2 MCPs) or cube (for 3 MCPs) root of the overall PMT gain.

<u>Usefulness:</u>

- 1. Fast measurement of the potocathode lifetime.
- 2.Proper PMT design for the lifetime improvement.

Lifetime estimation



Summary

- The dependence of specific QE degradation on the photon counting rate has been measured.
- It seems that the photocathode aging is determined by ions produced in the first MCP.
- Estimated lifetime of the tested MCP PMT is ~50 C of anode charge.